

Supplementary Information

Surface Oxygen Vacancies of TiO₂ Nanorods by Electron Beam Irradiation for Efficient Photoelectrochemical Water Splitting

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I . Calculation

Applied bias photon-to-current efficiency (ABPE)

ABPE were calculated by the equation (1)

$$ABPE = \frac{I(mA \cdot cm^{-2}) \times (1.23 - V_{bias})(V)}{P_{light}(mW \cdot cm^{-2})} \times 100\% \quad (1)$$

where I is the measured photocurrent density at corresponding wavelength, and P_{light} is the measured light power density at that wavelength (100 mW cm⁻² in this work).

V_{bias} is the applied bias between WE and RHE.

Calculation of carrier concentration (Nd)

The Nd of TiO₂, and EBI-TiO₂ photoanodes through the M-S plots were calculated by the equation (2):

$$Nd = \frac{2}{e\varepsilon\varepsilon_0} \left[\frac{d(1/C^2)}{dv} \right]^{-1} \quad (2)$$

where ε_0 is the permittivity of free space (8.86×10^{-12} F/m), ε is the dielectric constant of TiO₂, and e is electron charge (1.6×10^{-19} C). and $d(1/C^2)/dv$ is the slope of the curve shown in M-S plots (Fig. 6a).

Charge separation efficiency (η)

The photocurrent (J_{ph}) can be identified as a product of the theoretical photocurrent (J_{abs}) dependent on the light absorption, the charge separation efficiency (η_{sep}), and the interfacial charge transfer efficiency (η_{inj}), which is expressed by the following relation:

$$J_{ph} = J_{abs} \times \eta_{sep} \times \eta_{inj} \quad (3)$$

With the addition of a scavenger (Na₂SO₃), η_{inj} is equal to 1, and thus, η_{sep} can be calculated as the following relationship:

$$\eta_{sep} = \frac{J_{sulfite}}{J_{abs}} \times 100\% \quad (4)$$

$$\eta_{inj} = \frac{J_{ph}}{J_{sulfite}} \times 100\% \quad (5)$$

II . Morphology of the photoanodes

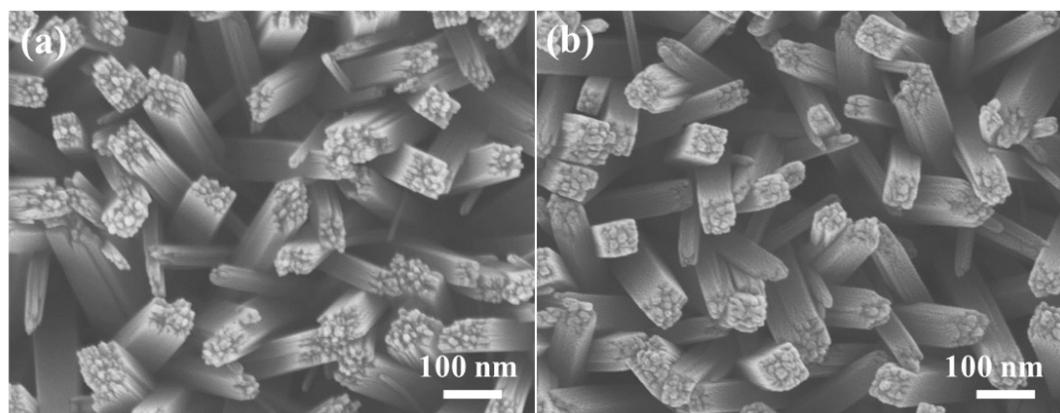


Fig. S1 SEM images of (a) TiO_2 and (b) EBI- TiO_2 .

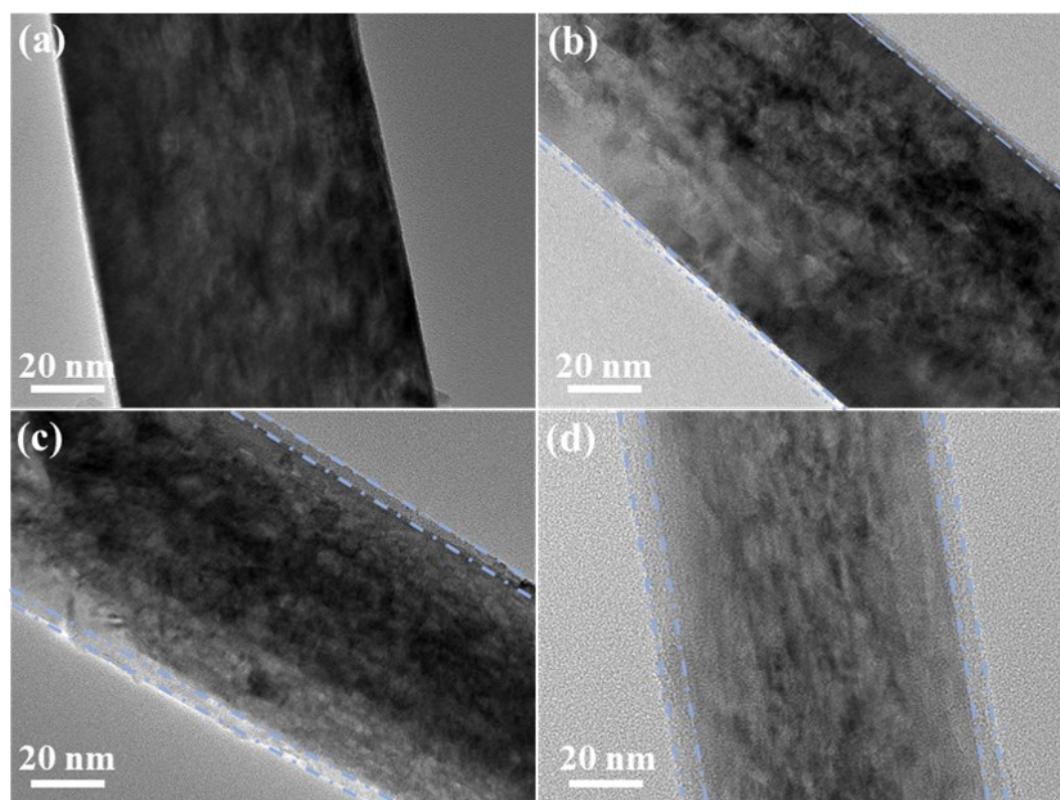


Fig. S2 TEM images of a single nanorod of (a) TiO_2 , (b) EBI- TiO_2 -15, (c) EBI- TiO_2 -30, and (d) EBI- TiO_2 -60.

III. XPS spectra of the photoanodes

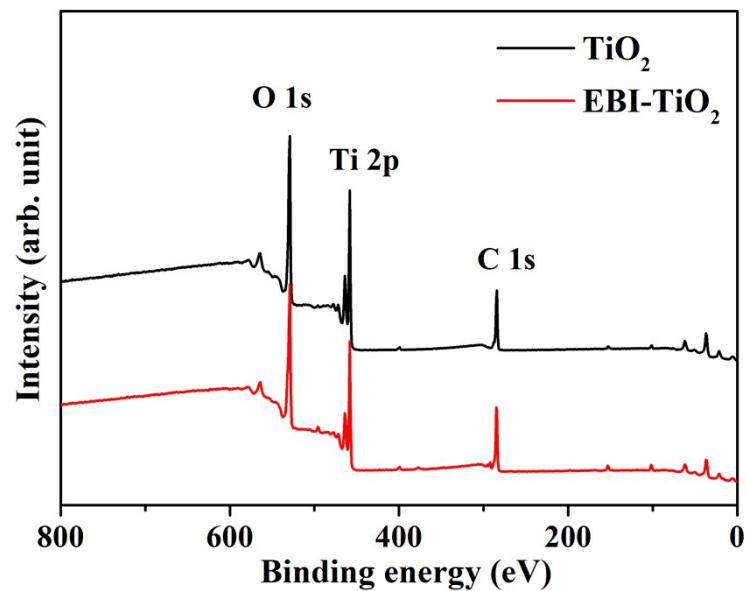


Fig. S3 The survey XPS spectra of TiO_2 and EBI- TiO_2 .

IV. Photoelectrochemical analysis of the photoanodes

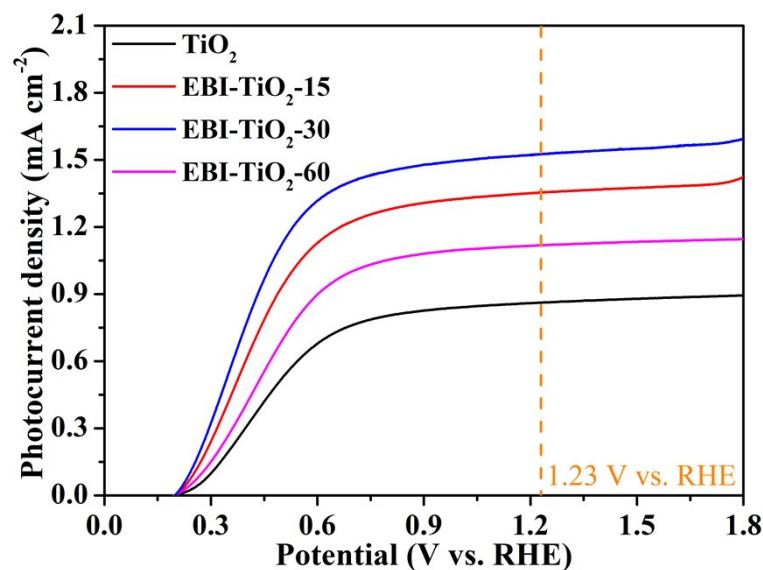


Fig. S4 Photocurrent density-potential (J-V) curves of EBI- TiO_2 with different irradiation dose.

V. Light harvesting efficiency and Electron flux of the photoanodes

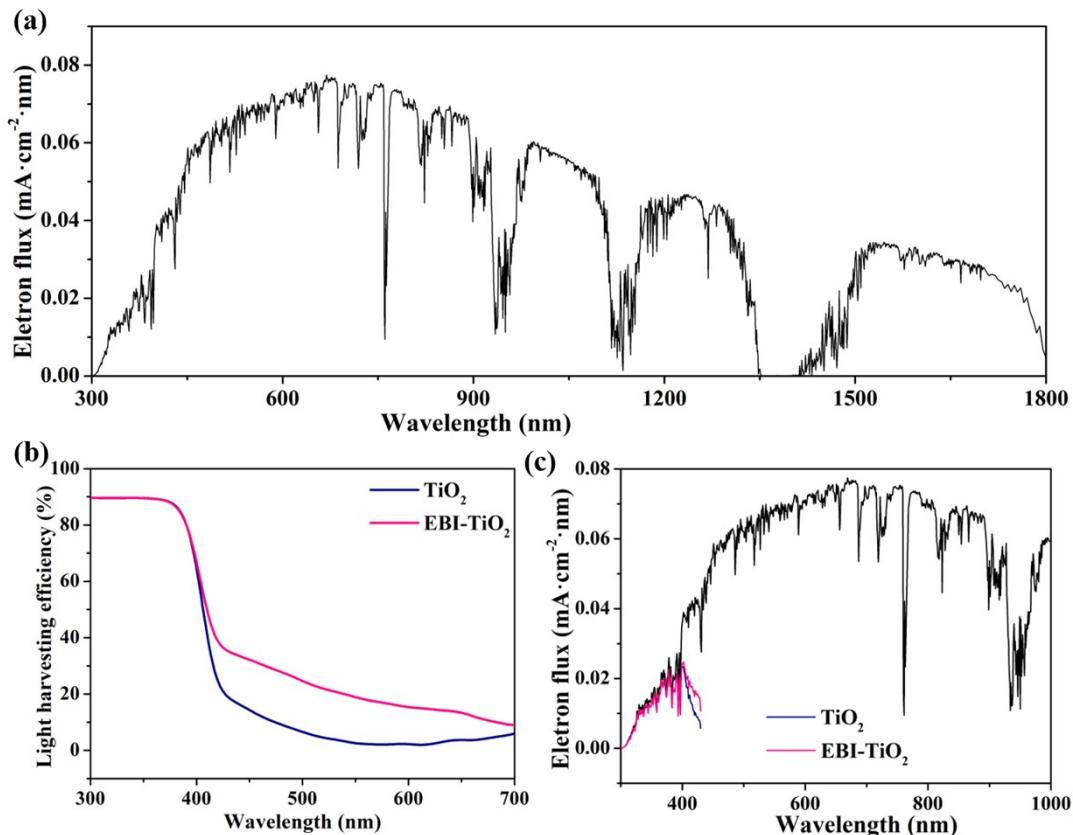


Fig. S5 (a) Electron flux of AM 1.5G solar spectrum. (b) Light harvesting efficiency (η_{LHE}) calculated from the absorption data (η_{ABS}) using the equation $\eta_{LHE} = (1 - 10^{-\eta_{ABS}}) \times 100\%$, and (c) Electron flux of TiO₂ and EBI-TiO₂.

VI. Comparison of J-V curves measured for WO and SO

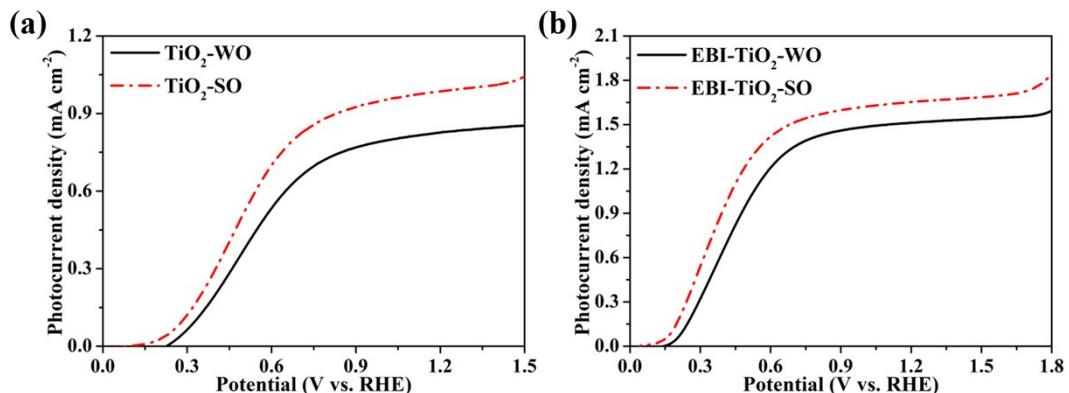


Fig. S6 Comparison of J-V curves measured between (a) TiO_2 and (b) EBI- TiO_2 for water oxidation (WO) in 1 M NaOH solution and sulfite oxidation (SO) measured in 1 M NaOH with 1 M Na_2SO_3 as the hole scavenger under AM 1.5 G illumination. sulfite oxidation.

VII. Comparison study of PEC performance

Table S1. Comparison of PEC activity of TiO₂-based photoanodes by recently developed V_O generation methods and our EBI approach.

Photoanode material	Methods	Photocurrent density	Test condition	Reference
O&H-Rutile TiO ₂ /Pd sample	Pd chemical coating, then H ₂ reduction	1.5 mA cm ⁻² at 1.23 V _{RHE}	1 M NaOH	[1]
“crystal-deficient” overlayer-TiO ₂ NW	solution based lithium reduction	2.0 mA cm ⁻² at 1.23 V _{RHE}	1 M NaOH	[2]
high vacuum annealed TiO ₂ NRAs	annealed in high vacuum	2.02 mA cm ⁻² at 0.8 V _{SCE}	0.5 M Na ₂ SO ₄	[3]
TiO ₂ /STO/r-STO NWs	heated in NaBH ₄ and Ar flow	0.32 mA cm ⁻² at 1.23 V _{RHE}	1 M KOH	[4]
TiO ₂ -Ar	annealed in Ar atmosphere	0.98 mA cm ⁻² at 1.23 V _{RHE}	1 M NaOH	[5]
H/TiO ₂ nanoarrays	exposed to 10 Torr of H ₂ at 400 °C	2.0 mA cm ⁻² at 1.23 V _{RHE}	1 M KOH	[6]
flame-reduced TiO ₂ NWs	high temperature (>1000 °C) flame reduction	1.74 mA cm ⁻² at 1.23 V _{RHE}	1 M KOH	[7]
Co-Pi/EBI-TiO ₂	electron beam irradiation	1.97 mA cm ⁻² at 1.23 V _{RHE}	1 M NaOH	This work

VIII. Fitting results of Nyquist plots

Table S2. EIS results of the TiO₂ and EBI/Sn:TiO₂ NRs.

Samples	R _s (Ω)	R ₁ (Ω)	CPE1 (μF)	R ₂ (Ω)	CPE2 (μF)
TiO ₂	38.59	312.50	0.43	12253.00	32.22
EBI-TiO ₂	21.48	68.31	9.32	5691.00	32.32

IX. References

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